CY2CP1504

1:4 LVCMOS to LVPECL Fanout Buffer with Selectable Clock Input

Features

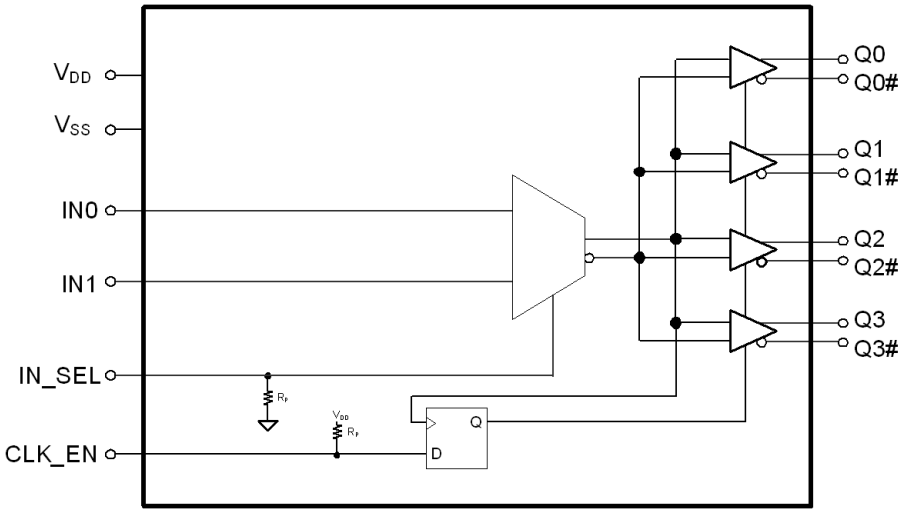
- Select one of two low-voltage complementary metal oxide semiconductor (LVCMOS) inputs to distribute to four low-voltage positive emitter-coupled logic (LVPECL) output pairs
- 30-ps maximum output-to-output skew
- 480-ps maximum propagation delay
- 0.15-ps maximum additive RMS phase jitter at 156.25 MHz (12-kHz to 20-MHz offset)
- Up to 250 MHz operation
- Synchronous clock enable function
- 20-Pin thin shrunk small outline package (TSSOP) package
- 2.5-V or 3.3-V operating voltage [1]
- Commercial and industrial operating temperature range

Functional Description

The CY2CP1504 is an ultra-low noise, low-skew, low-propagation delay 1:4 LVCMOS to LVPECL fanout buffer targeted to meet the requirements of high-speed clock distribution applications. The CY2CP1504 can select between two separate LVCMOS input clocks using the IN_SEL pin. The synchronous clock enable function ensures glitch-free output transitions during enable and disable periods. The device has a fully differential internal architecture that is optimized to achieve low additive jitter and low skew at operating frequencies of up to 250 MHz.

For a complete list of related documentation, click here.

Logic Block Diagram

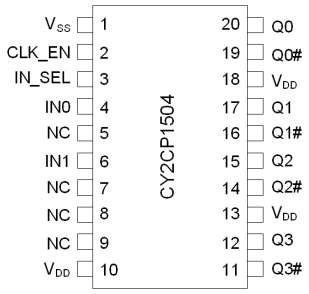


Note
1. Input AC-coupling capacitors are required for voltage-translation applications.

Contents

Pin Configurations

Figure 1. 20-pin TSSOP Package pinout



Pin Definitions

Pin No.	Pin Name	Pin Type	Description
1	V_{SS}	Power	Ground
2	CLK_EN	Input	Synchronous clock enable. LVCMOS/low-voltage transistor-transistor logic (LVTTL). When CLK_EN = Low, Q(0:3) outputs are held low and Q(0:3)# outputs are held high
3	IN_SEL	Input	Input clock select pin. LVCMOS/LVTTL; When IN_SEL = Low, input IN0 is active When IN_SEL = High, input IN1 is active
4	IN0	Input	LVCMOS input clock. Active when IN_SEL = Low
5, 7, 8, 9	NC		No connection
6	IN1	Input	LVCMOS input clock. Active when IN_SEL = High
10, 13, 18	V_{DD}	Power	Power supply
11, 14, 16, 19	Q(0:3)#	Output	LVPECL complementary output clocks
12, 15, 17, 20	Q(0:3)	Output	LVPECL output clocks

Absolute Maximum Ratings

Parameter	Description	Condition	Min	Max	Unit
V_{DD}	Supply voltage	Nonfunctional	–0.5	4.6	V
V_{IN}[2]	Input voltage, relative to V_{SS}	Nonfunctional	–0.5	lesser of 4.0 or V_{DD} + 0.4	V
V_{OUT}[2]	DC output or I/O voltage, relative to V_{SS}	Nonfunctional	–0.5	lesser of 4.0 or V_{DD} + 0.4	V
T_S	Storage temperature	Nonfunctional	–55	150	°C
ESD_{HBM}	Electrostatic discharge (ESD) protection (Human body model)	JEDEC STD 22-A114-B	2000	–	V
L_U	Latch up		Meets or exceeds JEDEC Spec JESD78B IC latch up test		
UL–94	Flammability rating	At 1/8 in	V-0		
MSL	Moisture sensitivity level		3		

Operating Conditions

Parameter	Description	Condition	Min	Max	Unit
V_{DD}	Supply voltage	2.5 V supply	2.375	2.625	V
		3.3 V supply	3.135	3.465	V
T_A	Ambient operating temperature	Commercial	0	70	°C
		Industrial	–40	85	°C
t_{PU}	Power ramp time	Power-up time for V_{DD} to reach minimum specified voltage (power ramp must be monotonic)	0.05	500	ms

Note
2. The voltage on any I/O pin cannot exceed the power pin during power up. Power supply sequencing is not required.

DC Electrical Specifications

(V_{DD} = 3.3 V ± 5% or 2.5 V ± 5%; T_A = 0 °C to 70 °C (Commercial) or –40 °C to 85 °C (Industrial))

Parameter	Description	Condition	Min	Max	Unit
I_{DD}	Operating supply current	All LVPECL outputs floating (internal I_{DD})	–	61	mA
V_{IH1}	Input high voltage, All inputs	V_{DD} = 3.3 V	2.0	V_{DD} + 0.3	V
V_{IL1}	Input low voltage, All inputs	V_{DD} = 3.3 V	–0.3	0.8	V
V_{IH2}	Input high voltage, All inputs	V_{DD} = 2.5 V	1.7	V_{DD} + 0.3	V
V_{IL2}	Input low voltage, All inputs	V_{DD} = 2.5 V	–0.3	0.7	V
I_{IH}	Input high current, All inputs	Input = V_{DD}[3]	–	150	µA
I_{IL}	Input low current, All inputs	Input = V_{SS}[3]	–150	–	µA
V_{OH}	LVPECL output high voltage	Terminated with 50 Ω to V_{DD} – 2.0 [4]	V_{DD} – 1.20	V_{DD} – 0.70	V
V_{OL}	LVPECL output low voltage	Terminated with 50 Ω to V_{DD} – 2.0 [4]	V_{DD} – 2.0	V_{DD} – 1.63	V
R_P	Internal pull-up/pull-down resistance	CLK_EN has pull-up only IN_SEL has pull-down only	60	165	kΩ
C_{IN}	Input capacitance	Measured at 10 MHz; per pin	–	3	pF

Thermal Resistance

Parameter [5]	Description	Test Conditions	20-pin TSSOP	Unit
θ_{JA}	Thermal resistance (junction to ambient)	Test conditions follow standard test methods and procedures for measuring thermal impedance, in accordance with EIA/JESD51.	80	°C/W
θ_{JC}	Thermal resistance (junction to case)		16	°C/W

Notes
3. Positive current flows into the input pin, negative current flows out of the input pin.
4. Refer to Figure 2 on page 7.
5. These parameters are guaranteed by design and are not tested.

AC Electrical Specifications

(V_{DD} = 3.3 V ± 5% or 2.5 V ± 5%; T_A = 0 °C to 70 °C (Commercial) or –40 °C to 85°C (Industrial))

Parameter	Description	Condition	Min	Typ	Max	Unit
F_{IN}	Input frequency		DC	–	250	MHz
F_{OUT}	Output frequency	$F_{OUT} = F_{IN}$	DC	–	250	MHz
V_{PP}	LVPECL differential output voltage peak- to-peak, single-ended. Terminated with 50 Ω to V_{DD} – 2.0 [4]	Fout = DC to 150 MHz	600	–	–	mV
		Fout = >150 MHz to 250 MHz	400	–	–	mV
t_{PD}[6]	Propagation delay input to output pair	Input rise/fall time < 1.5 ns (20% to 80%)	–	–	480	ps
t_{ODC}[7]	Output duty cycle	Rail-to-rail input swing, 50% input DTCY measured at Vdd/2	45	–	55	%
t_{SK1}[8]	Output-to-output skew	Any output to any output, with same load conditions at DUT	–	–	30	ps
$t_{SK1\ D}$[8]	Device-to-device output skew	Any output to any output between two or more devices. Devices must have the same input and have the same output load.	–	–	150	ps
PN_{ADD}	Additive RMS phase noise 156.25-MHz Input Rise/fall time < 150 ps (20% to 80%) V_{ID} > 400 mV	Offset = 1 kHz	–	–	–120	dBc/Hz
		Offset = 10 kHz	–	–	–130	dBc/Hz
		Offset = 100 kHz	–	–	–135	dBc/Hz
		Offset = 1 MHz	–	–	–150	dBc/Hz
		Offset = 10 MHz	–	–	–150	dBc/Hz
		Offset = 20 MHz	–	–	–150	dBc/Hz
t_{JIT}[9]	Additive RMS phase jitter (Random)	156.25 MHz sinewave, 12 kHz to 20 MHz offset; input swing = 2.2V, $V_{bias} = V_{DD}/2$	–	–	0.15	ps
t_R, t_F[10]	Output rise/fall time	50% duty cycle at input, 20% to 80% of full swing (V_{OL} to V_{OH}) Input rise/fall time < 1.5 ns (20% to 80%)	–	–	300	ps
t_{SOD}	Time from clock edge to outputs disabled	Synchronous clock enable (CLK_EN) switched Low	–	–	700	ps
t_{SOE}	Time from clock edge to outputs enabled	Synchronous clock enable (CLK_EN) switched high	–	–	700	ps

Notes
6. Refer to Figure 3 on page 7.
7. Refer to Figure 4 on page 7.
8. Refer to Figure 5 on page 7.
9. Refer to Figure 6 on page 8.
10. Refer to Figure 7 on page 8.

Figure 2. Output Differential Voltage

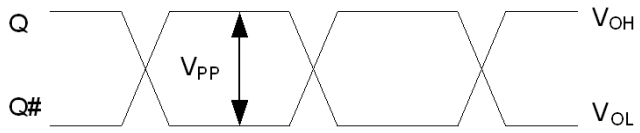


Figure 3. Input to Any Output Pair Propagation Delay

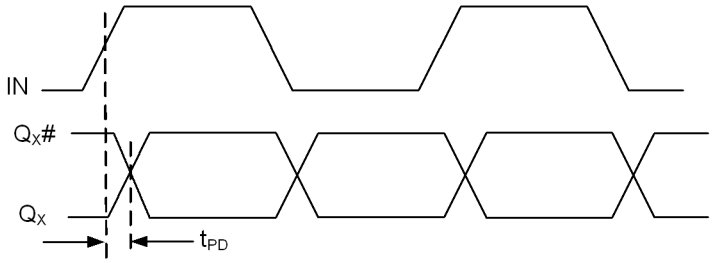


Figure 4. Output Duty Cycle

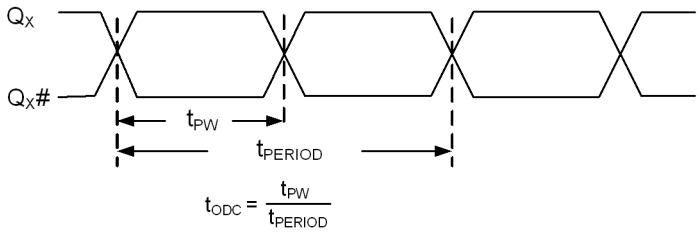


Figure 5. Output-to-Output and Device-to-Device Skew

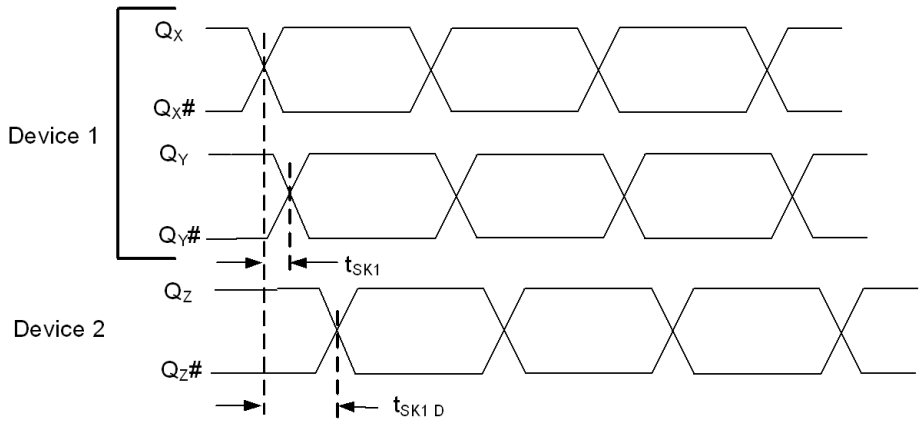


Figure 6. RMS Phase Jitter

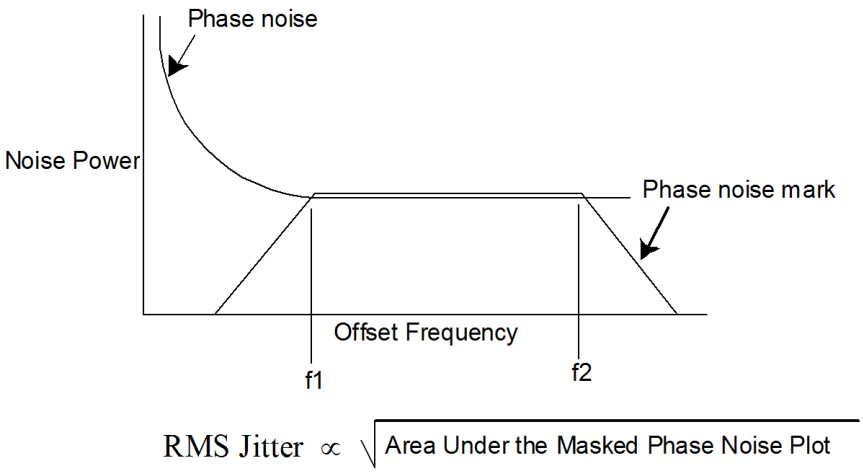


Figure 7. Output Rise/Fall Time

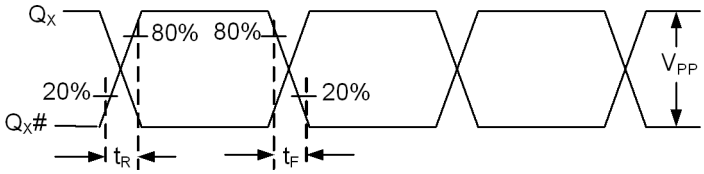
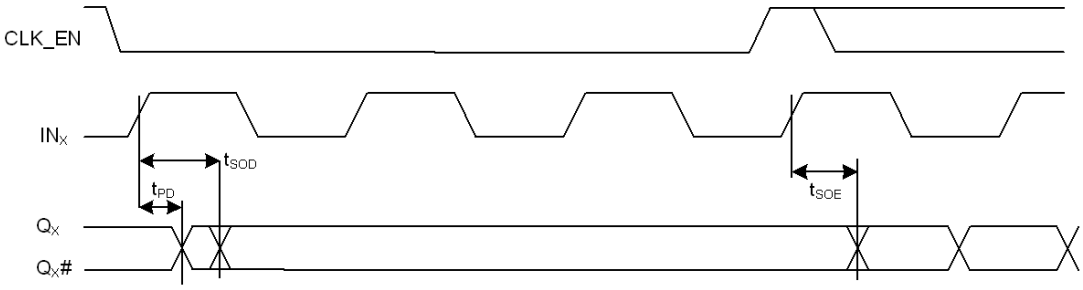


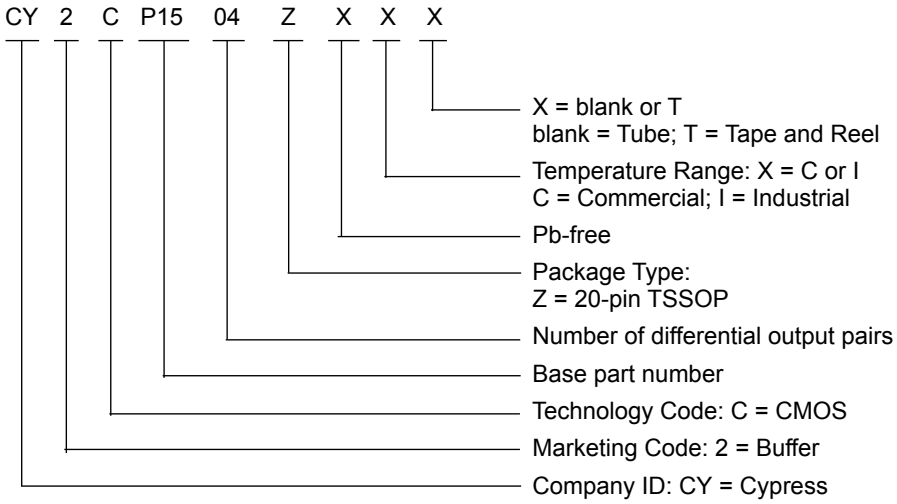
Figure 8. Synchronous Clock Enable Timing



Ordering Information

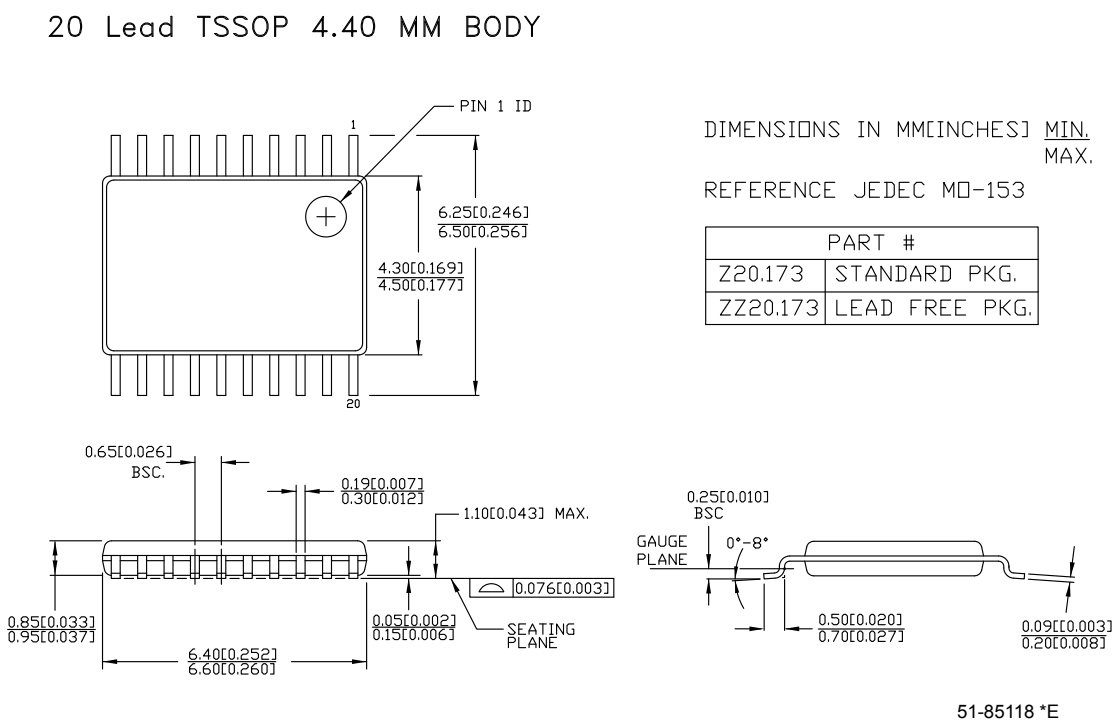
Part Number	Type	Production Flow
Pb-free		
CY2CP1504ZXC	20-pin TSSOP	Commercial, 0 °C to 70 °C
CY2CP1504ZXCT	20-pin TSSOP – Tape and Reel	Commercial, 0 °C to 70 °C
CY2CP1504ZXI	20-pin TSSOP	Industrial, –40 °C to 85 °C
CY2CP1504ZXIT	20-pin TSSOP – Tape and Reel	Industrial, –40 °C to 85 °C

Ordering Code Definitions



Package Diagram

Figure 9. 20-pin TSSOP (4.40 mm Body) Z20.173/ZZ20.173 Package Outline, 51-85118



Acronyms

Table 1. Acronyms Used in this Document

Acronym	Description
ESD	electrostatic discharge
HBM	human body model
JEDEC	joint electron devices engineering council
LVDS	low-voltage differential signal
LVCMOS	low-voltage complementary metal oxide semiconductor
LVPECL	low-voltage positive emitter-coupled logic
LVTTL	low-voltage transistor-transistor logic
RMS	root mean square
TSSOP	thin shrunk small outline package

Document Conventions

Units of Measure

Table 2. Units of Measure

Symbol	Unit of Measure
°C	degree Celsius
dBc	decibels relative to the carrier
GHz	gigahertz
Hz	hertz
kΩ	kilohm
µA	microampere
µF	microfarad
µs	microsecond
mA	milliampere
ms	millisecond
mV	millivolt
MHz	megahertz
ns	nanosecond
Ω	ohm
pF	picofarad
ps	picosecond
V	volt
W	watt

Document History Page

Document Title: CY2CP1504, 1:4 LVCMOS to LVPECL Fanout Buffer with Selectable Clock Input Document Number: 001-56313				
Revision	**ECN**	**Orig. of Change**	**Submission Date**	**Description of Change**
**	2782891	CXQ	10/09/09	New data sheet
*A	2838916	CXQ	05/01/2010	Changed status from “ADVANCE” to “PRELIMINARY”. Changed from 0.34 ps to 0.25 ps maximum additive jitter in “Features” on page 1 and in t_{JIT} in the AC Electrical Specs table on page 5. Added t_{PU} spec to the Operating Conditions table on page 3. Changed max I_{DD} spec in the DC Electrical Specs table on page 4 from 60 mA to 61 mA. Changed V_{OH} in the DC Electrical Specs table on page 4: minimum from V_{DD} - 1.15V to V_{DD} - 1.20V; maximum from V_{DD} - 0.75V to V_{DD} - 0.70V. Removed V_{OD} spec from the DC Electrical Specs table on page 4. Added R_P spec in the DC Electrical Specs table on page 4. Min = 60 kΩ, Max = 140 kΩ. Added a measurement definition for C_{IN} in the DC Electrical Specs table on page 4. Added V_{PP} spec to the AC Electrical Specs table on page 5. V_{PP} min = 600 mV for DC - 150 MHz and min = 400 mV for 150 MHz to 250 MHz. Changed letter case and some names of all the timing parameters in the AC Electrical Specs table on page 5 to be consistent with EROS. Lowered all additive phase noise mask specs by 3 dB in the AC Electrical Specs table on page 5. Added condition to t_R and t_F specs in the AC Electrical specs table on page 5 that input rise/fall time must be less than 1.5 ns (20% to 80%). Changed letter case and some names of all the timing parameters in Figures 2, 3, 4, 5 and 7, to be consistent with EROS.
*B	3011766	CXQ	08/20/2010	Changed from 0.25 ps to 0.15 ps maximum additive jitter in “Features” on page 1 and in t_{JIT} in the AC Electrical Specs table on page 6. Added note 2 to describe I_{IH} and I_{IL} specs. Removed reference to data distribution from “Functional Description”. Updated phase noise specs for 1 k/10 k/100 k/1 M/10 M/20 MHz offset to -120/-130/-135/-150/-150/-150dBc/Hz, respectively, in the AC Electrical Specs table. Updated package diagram. Added Acronyms and Ordering Code Definition.
*C	3017258	CXQ	08/27/2010	Corrected Output Rise/Fall time diagram.
*D	3100234	CXQ	11/18/2010	Changed V_{IN} and V_{OUT} specs from 4.0V to “lesser of 4.0 or V_{DD} + 0.4” Removed 200mA min LU spec, replaced with “Meets or exceeds JEDEC Spec JESD78B IC Latchup Test” Changed C_{IN} condition to “Measured at 10 MHz”. Removed t_R and t_F input specs from AC specs table. Changed t_{ODC} from 48/52% to 45/55%, changed condition to “Rail-to-rail input swing, 50% input duty cycle measured at Vdd/2”. Changed phase jitter condition to “156.25 MHz sinewave, 12 kHz to 20 MHz offset; input swing = 2.2V, V_{bias} = V_{DD}/2 “ Removed t_S and t_H specs from AC specs table.
*E	3137726	CXQ	01/13/2011	Removed “Preliminary” status heading. Removed resistors from IN0/IN1 in Logic Block Diagram. Added Figure 8 to describe T_{SOE} and T_{SOD}.
*F	3182321	CXQ	02/25/11	Post to external web.
*G	3208968	CXQ	03/29/2011	Changed R_P max from 140 kΩ to 165 kΩ and updated R_P in Logic Block Diagram.

Document History Page (continued)

Document Title: CY2CP1504, 1:4 LVCMOS to LVPECL Fanout Buffer with Selectable Clock Input Document Number: 001-56313				
Revision	**ECN**	**Orig. of Change**	**Submission Date**	**Description of Change**
*H	3878020	PURU	01/21/2013	Updated Package Diagram: spec 51-85118 – Changed revision from *C to *D. Updated to new template.
*I	4587249	PURU	12/03/2014	Updated Functional Description: Added “For a complete list of related documentation, click here.” at the end. Updated Package Diagram: spec 51-85118 – Changed revision from *D to *E.
*J	5267558	PSR	05/13/2016	Added Thermal Resistance. Updated to new template.

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